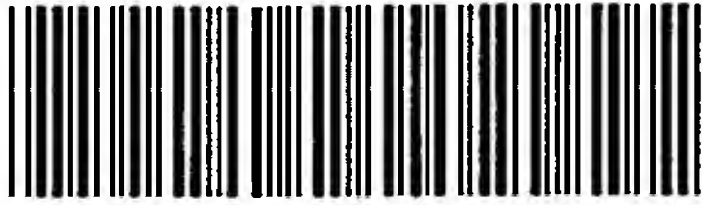


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,250	CHEN ET AL.	
	Examiner	Art Unit	
	Long K. Tran	2818	

SEARCHED			
Class	Subclass	Date	Examiner
257	59,72	2/8/2005	LKT
349	149,150	2/8/2005	LKT
349	151,152	2/8/2005	LKT
349	129	2/8/2005	LKT
324	770	2/8/2005	LKT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	59,72	2/8/2005	LKT
349	149,150	2/8/2005	LKT
349	151,152	2/8/2005	LKT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searched	2/8/2005	LKT
EAST searched	2/9/2005	LKT